

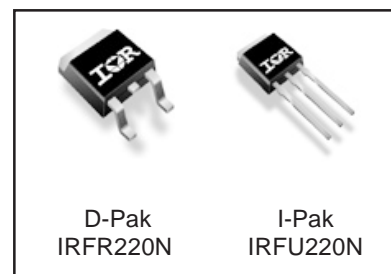
Applications

- High frequency DC-DC converters

| V_{DSS} | $R_{DS(on)}$ max (m Ω) | I_D |
|-----------|--------------------------------|-------|
| 200V | 600 | 5.0A |

Benefits

- Low Gate to Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective C_{OSS} to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|-----------------------------------|--|------------------------|---------------------|
| I_D @ $T_C = 25^\circ\text{C}$ | Continuous Drain Current, V_{GS} @ 10V | 5.0 | A |
| I_D @ $T_C = 100^\circ\text{C}$ | Continuous Drain Current, V_{GS} @ 10V | 3.5 | |
| I_{DM} | Pulsed Drain Current ① | 20 | |
| P_D @ $T_C = 25^\circ\text{C}$ | Power Dissipation | 43 | W |
| | Linear Derating Factor | 0.71 | W/ $^\circ\text{C}$ |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| dv/dt | Peak Diode Recovery dv/dt ③ | 7.5 | V/ns |
| T_J | Operating Junction and | -55 to + 175 | $^\circ\text{C}$ |
| T_{STG} | Storage Temperature Range | | |
| | Soldering Temperature, for 10 seconds | 300 (1.6mm from case) | |

Typical SMPS Topologies

- Telecom 48V input Forward Converters

Notes ① through ⑤ are on page 10

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Static @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|--------------------------------------|--------------------------------------|------|------|------|-------|--|
| V _{(BR)DSS} | Drain-to-Source Breakdown Voltage | 200 | — | — | V | V _{GS} = 0V, I _D = 250μA |
| ΔV _{(BR)DSS/ΔT_J} | Breakdown Voltage Temp. Coefficient | — | 0.23 | — | V/°C | Reference to 25°C, I _D = 1mA ④ |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | — | — | 600 | mΩ | V _{GS} = 10V, I _D = 2.9A ④ |
| V _{GS(th)} | Gate Threshold Voltage | 2.0 | — | 4.0 | V | V _{DS} = V _{GS} , I _D = 250μA |
| I _{DSS} | Drain-to-Source Leakage Current | — | — | 25 | μA | V _{DS} = 200V, V _{GS} = 0V |
| | | — | — | 250 | | V _{DS} = 160V, V _{GS} = 0V, T _J = 150°C |
| I _{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | V _{GS} = 20V |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | V _{GS} = -20V |

Dynamic @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|-----------------------|---------------------------------|------|------|------|-------|--|
| g _{fs} | Forward Transconductance | 2.6 | — | — | S | V _{DS} = 50V, I _D = 2.9A |
| Q _g | Total Gate Charge | — | 15 | 23 | nC | I _D = 2.9A |
| Q _{gs} | Gate-to-Source Charge | — | 2.4 | 3.6 | | V _{DS} = 160V |
| Q _{gd} | Gate-to-Drain ("Miller") Charge | — | 6.1 | 9.2 | | V _{GS} = 10V, |
| t _{d(on)} | Turn-On Delay Time | — | 6.4 | — | ns | V _{DD} = 100V |
| t _r | Rise Time | — | 11 | — | | I _D = 2.9A |
| t _{d(off)} | Turn-Off Delay Time | — | 20 | — | | R _G = 24Ω |
| t _f | Fall Time | — | 12 | — | | V _{GS} = 10V ④ |
| C _{iss} | Input Capacitance | — | 300 | — | pF | V _{GS} = 0V |
| C _{oss} | Output Capacitance | — | 53 | — | | V _{DS} = 25V |
| C _{rss} | Reverse Transfer Capacitance | — | 15 | — | | f = 1.0MHz |
| C _{oss} | Output Capacitance | — | 300 | — | | V _{GS} = 0V, V _{DS} = 1.0V, f = 1.0MHz |
| C _{oss} | Output Capacitance | — | 23 | — | | V _{GS} = 0V, V _{DS} = 160V, f = 1.0MHz |
| C _{oss eff.} | Effective Output Capacitance | — | 46 | — | | V _{GS} = 0V, V _{DS} = 0V to 160V ⑤ |
| | | | | | | |

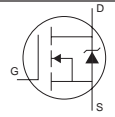
Avalanche Characteristics

| | Parameter | Typ. | Max. | Units |
|-----------------|--------------------------------|------|------|-------|
| E _{AS} | Single Pulse Avalanche Energy② | — | 46 | mJ |
| I _{AR} | Avalanche Current① | — | 2.9 | A |
| E _{AR} | Repetitive Avalanche Energy① | — | 4.3 | mJ |

Thermal Resistance

| | Parameter | Typ. | Max. | Units |
|------------------|----------------------------------|------|------|-------|
| R _{θJC} | Junction-to-Case | — | 3.5 | °C/W |
| R _{θJA} | Junction-to-Ambient (PCB mount)* | — | 50 | |
| R _{θJA} | Junction-to-Ambient | — | 110 | |

Diode Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|-----------------|--|--|------|------|-------|--|
| I _S | Continuous Source Current (Body Diode) | — | — | 5.0 | A | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I _{SM} | Pulsed Source Current (Body Diode) ① | — | — | 20 | | |
| V _{SD} | Diode Forward Voltage | — | — | 1.3 | V | T _J = 25°C, I _S = 2.9A, V _{GS} = 0V ④ |
| t _{rr} | Reverse Recovery Time | — | 90 | 140 | ns | T _J = 25°C, I _F = 2.9A |
| Q _{rr} | Reverse Recovery Charge | — | 320 | 480 | nC | di/dt = 100A/μs ④ |
| t _{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | | |

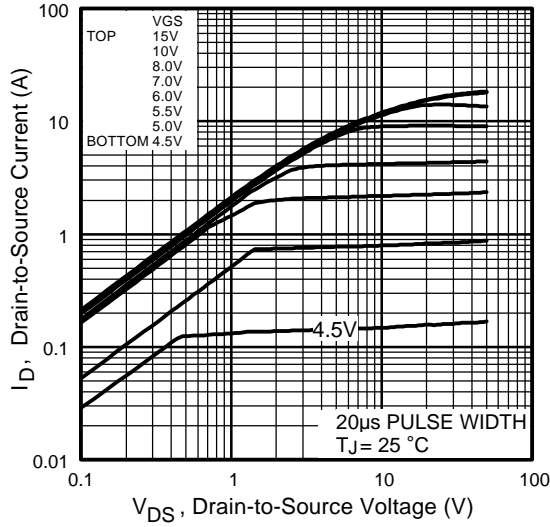


Fig 1. Typical Output Characteristics

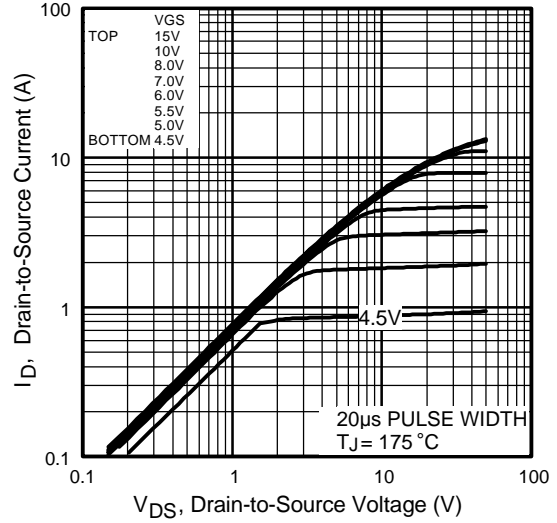


Fig 2. Typical Output Characteristics

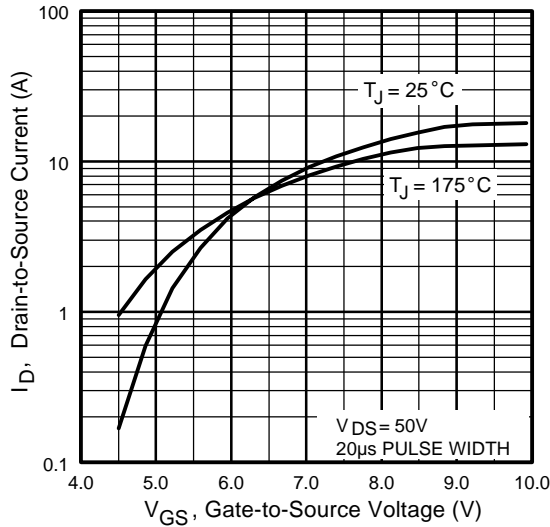


Fig 3. Typical Transfer Characteristics

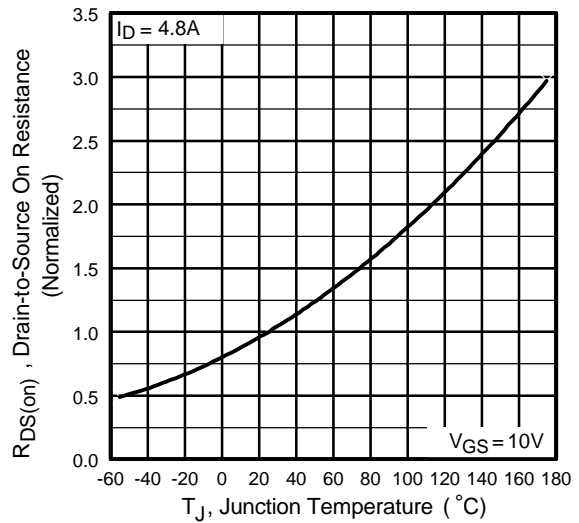


Fig 4. Normalized On-Resistance Vs. Temperature

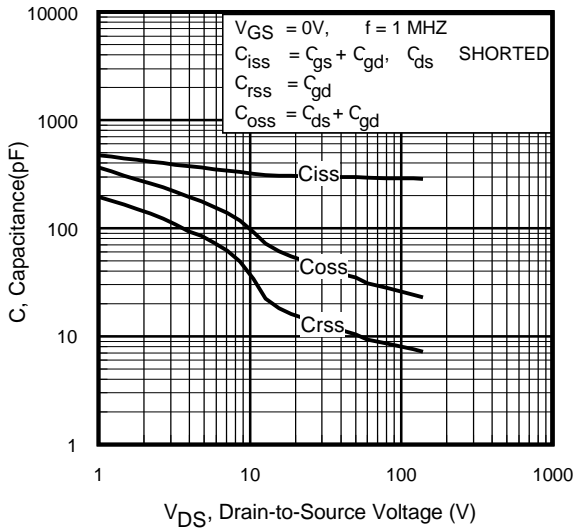


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

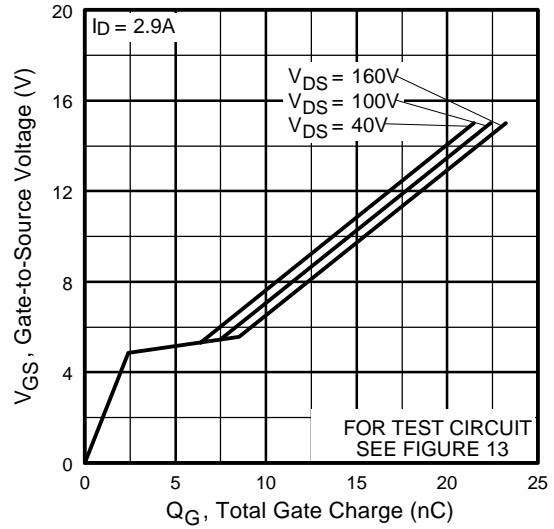


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

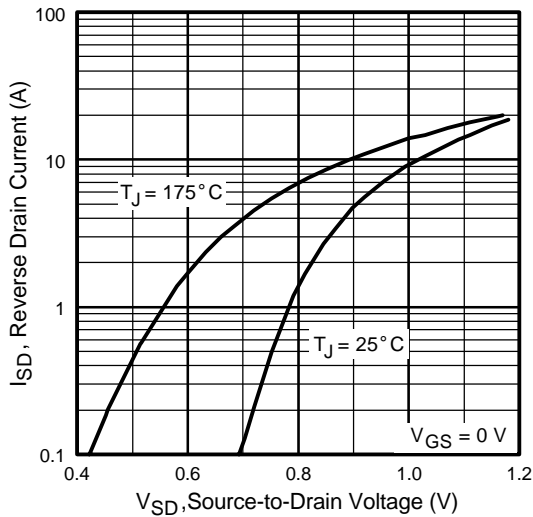


Fig 7. Typical Source-Drain Diode Forward Voltage

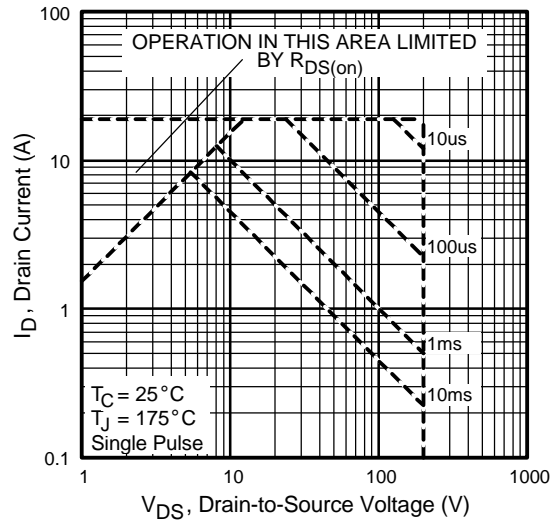


Fig 8. Maximum Safe Operating Area

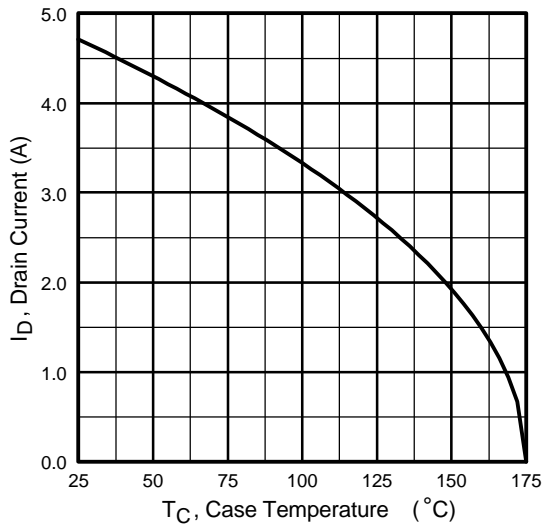


Fig 9. Maximum Drain Current Vs. Case Temperature

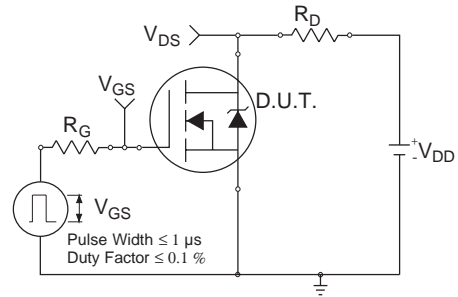


Fig 10a. Switching Time Test Circuit

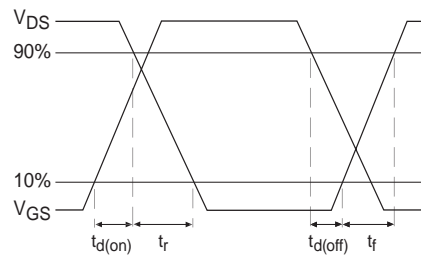


Fig 10b. Switching Time Waveforms

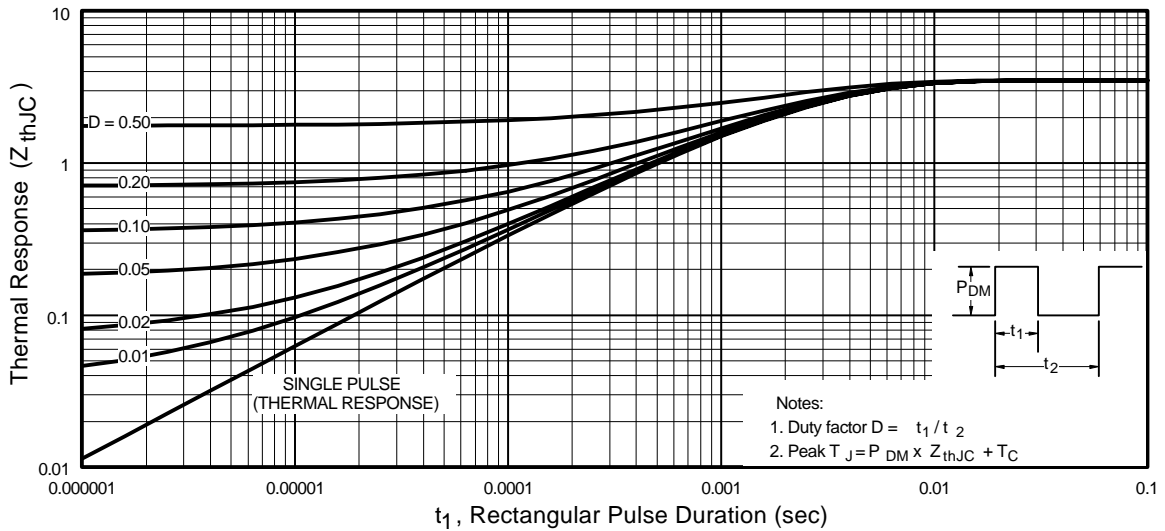


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

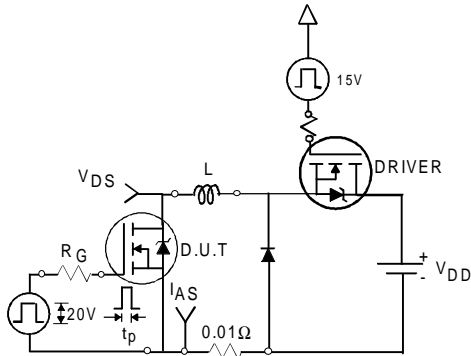


Fig 12a. Unclamped Inductive Test Circuit

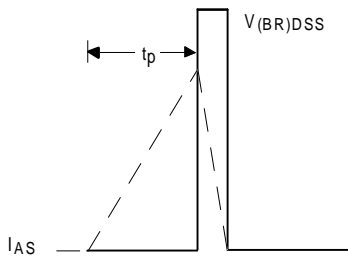


Fig 12b. Unclamped Inductive Waveforms

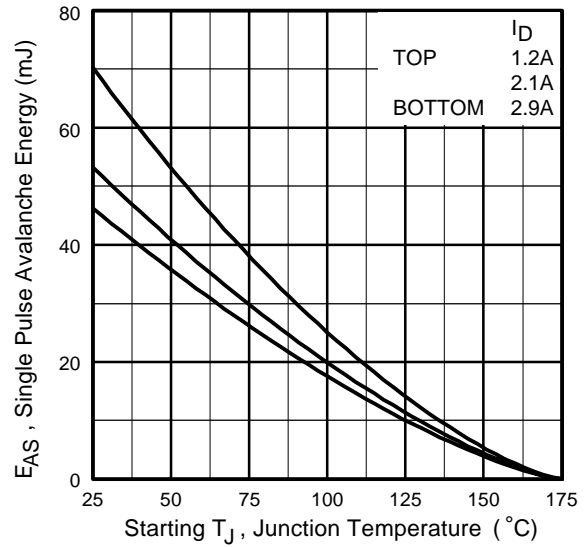


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

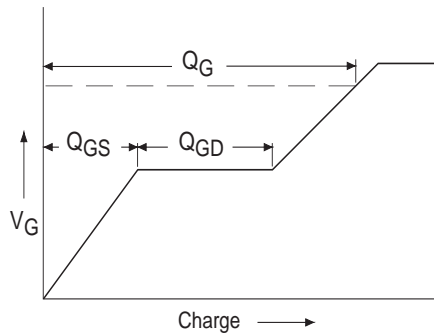


Fig 13a. Basic Gate Charge Waveform

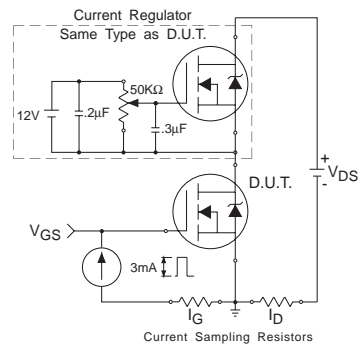
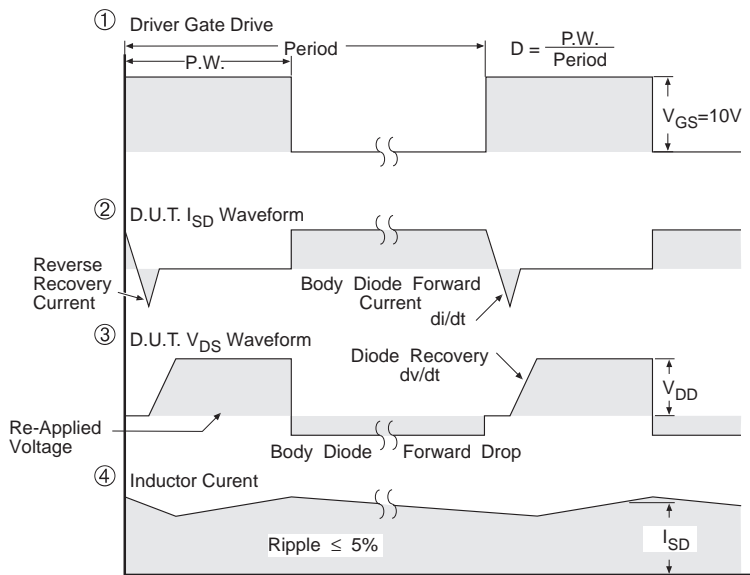
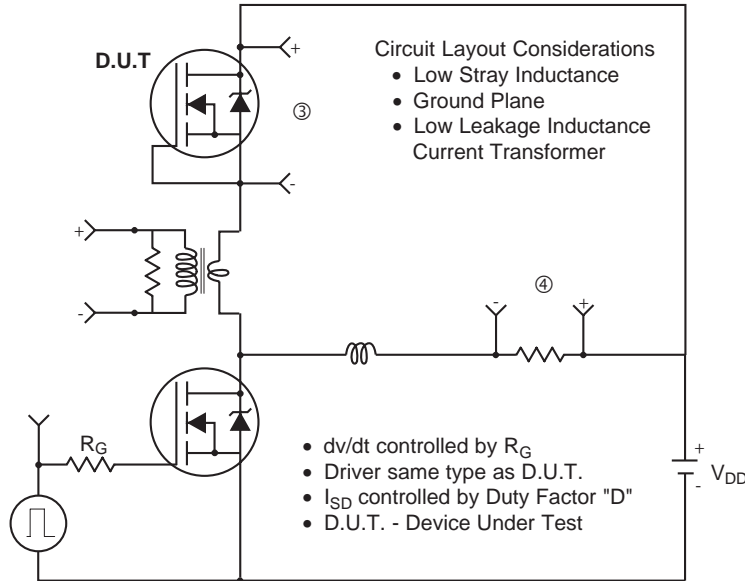


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



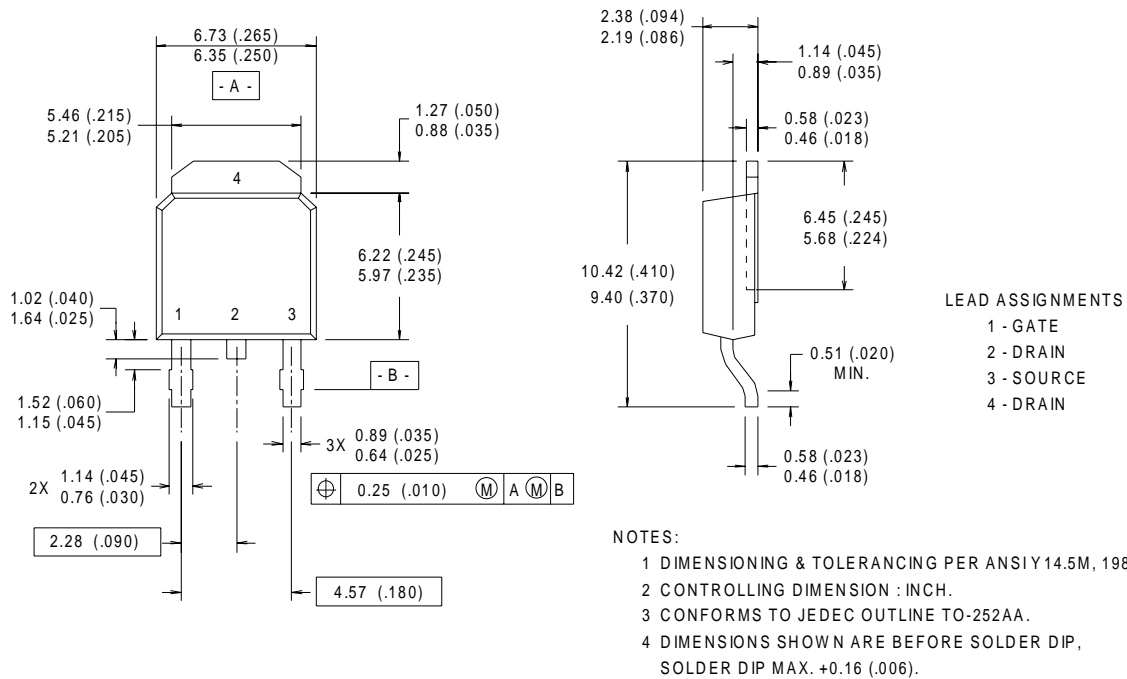
* $V_{GS} = 5V$ for Logic Level Devices

Fig 14. For N-Channel HEXFET® Power MOSFETs

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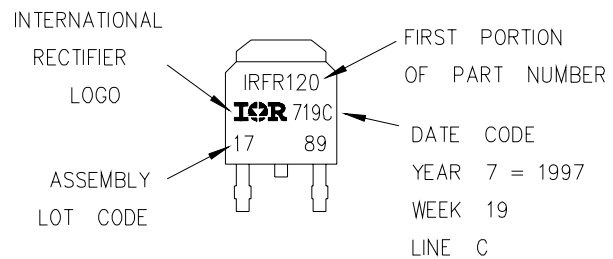
D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)



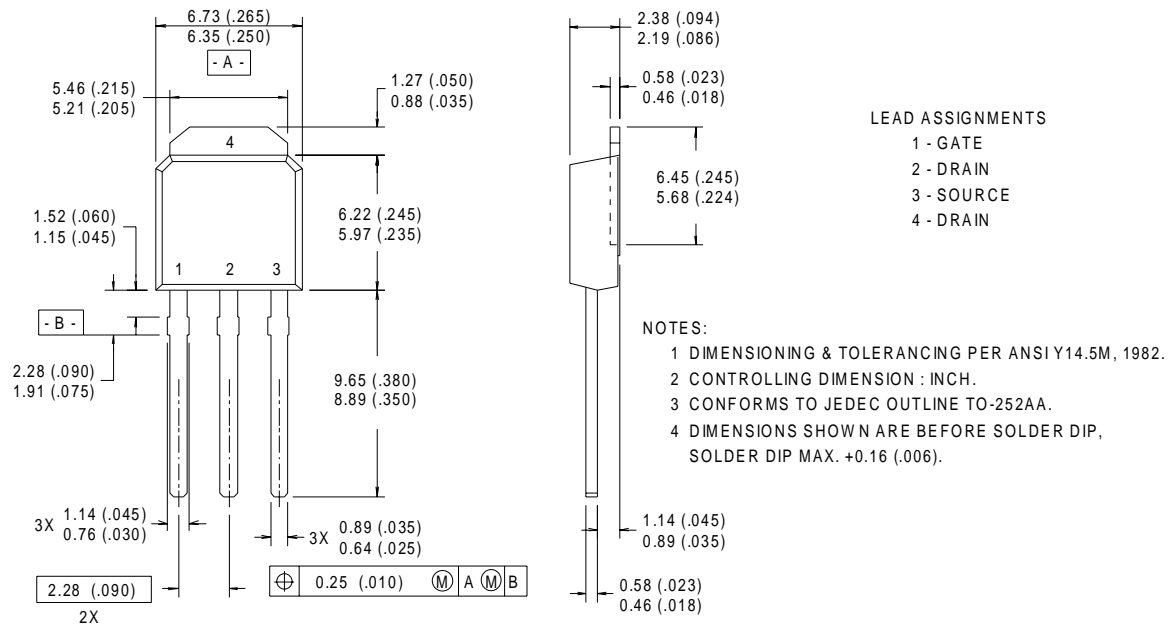
D-Pak (TO-252AA) Part Marking Information

EXAMPLE: THIS IS AN IRFR120
LOT CODE 1789
ASSEMBLED ON WW 19, 1997
IN THE ASSEMBLY LINE "C"



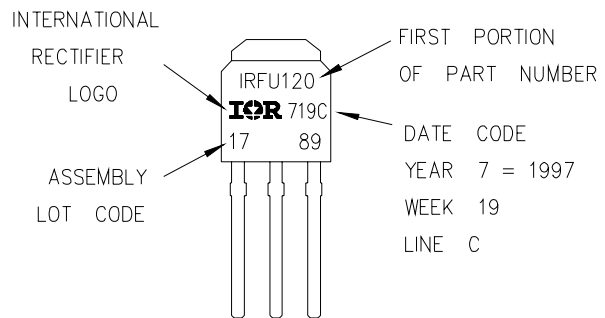
I-Pak (TO-251AA) Package Outline

Dimensions are shown in millimeters (inches)



I-Pak (TO-251AA) Part Marking Information

EXAMPLE: THIS IS AN IRFU120
 LOT CODE 1789
 ASSEMBLED ON WW 19, 1997
 IN THE ASSEMBLY LINE "C"

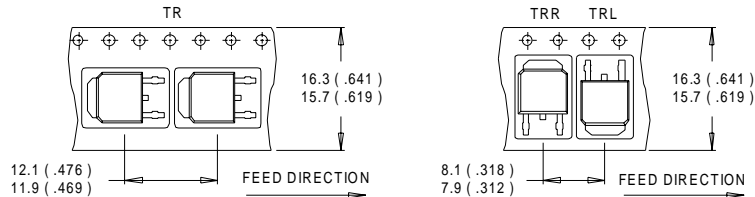


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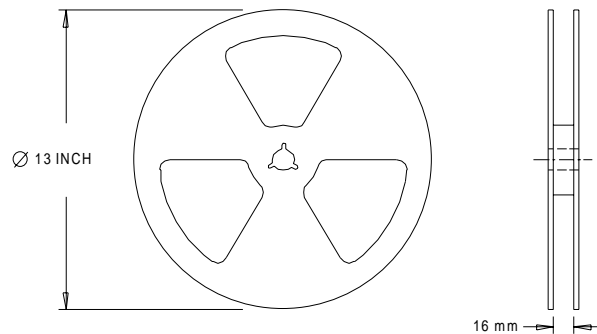
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D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES :
1. OUTLINE CONFORMS TO EIA-481.

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
 - ② Starting $T_J = 25^\circ\text{C}$, $L = 11\text{mH}$
 $R_G = 25\Omega$, $I_{AS} = 2.9\text{A}$.
 - ③ $I_{SD} \leq 2.9\text{A}$, $di/dt \leq 320\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$,
 $T_J \leq 175^\circ\text{C}$
 - ④ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
 - ⑤ C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- * When mounted on 1" square PCB (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994.

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